US00D631968S

(12) **United States Design Patent**
Sevel

(10) **Patent No.: US D631,968 S**
(45) **Date of Patent: ** Feb. 1, 2011**

(54) **ANALYSIS APPARATUS**

(75) Inventor: **Mai-Britt Sevel**, Copenhagen (DK)

(73) Assignee: **Atonomics A/S** (DK)

(**) Term: **14 Years**

(21) Appl. No.: **29/351,666**

(22) Filed: **Dec. 9, 2009**

(30) **Foreign Application Priority Data**

Jun. 12, 2009 (EM) 001545773

(51) **LOC (9) Cl.** **24-01**

(52) **U.S. Cl.** **D24/169**; D24/186; D10/81

(58) **Field of Classification Search** D10/81; 324/72.5, 556, 133, 149, 503, 543, 555, 66, 324/72, 754; 340/635; 362/119; D24/169, D24/186; 435/14, 283.1, 287.1, 4, 970; 702/19
See application file for complete search history.

(56) **References Cited**

U.S. PATENT DOCUMENTS

D381,749	S	*	7/1997	Lawrence et al.	D24/169
D399,959	S	*	10/1998	Prokop et al.	D24/169
D399,960	S	*	10/1998	Prokop et al.	D24/169
D402,369	S	*	12/1998	Prokop et al.	D24/169
D418,602	S	*	1/2000	Prokop et al.	D24/169
D424,956	S	*	5/2000	von Buelow et al.	D10/81
D508,565	S	*	8/2005	Nephin et al.	D24/186
D549,827	S	*	8/2007	Maeno et al.	D24/169
D601,257	S	*	9/2009	Berlinger et al.	D24/186
D607,569	S	*	1/2010	Yukikado et al.	D10/81

* cited by examiner

Primary Examiner—Antoine D Davis
(74) *Attorney, Agent, or Firm*—St. Onge Steward Johnston & Reens LLC

(57) **CLAIM**

The ornamental design for an analysis apparatus, as shown and described.

DESCRIPTION

FIG. **1** is a rear elevation view of a first embodiment of an analysis apparatus in accordance with the new design;

FIG. **2** is a bottom plan view thereof;

FIG. **3** is a front elevation view thereof;

FIG. **4** is a front and right side perspective view thereof;

FIG. **5** is a right side elevation view; the left side elevation view being a mirror image thereof;

FIG. **6** is a top plan view thereof;

FIG. **7** is a rear elevation view of a second embodiment of an analysis apparatus in accordance with the new design;

FIG. **8** is a bottom plan view thereof;

FIG. **9** is a front elevation view thereof;

FIG. **10** is a front and right side perspective view thereof;

FIG. **11** is a right side elevation view; the left side elevation view being a mirror image thereof;

FIG. **12** is a top plan view thereof;

FIG. **13** is a rear elevation view of a third embodiment of an analysis apparatus in accordance with the new design;

FIG. **14** is a bottom plan view thereof;

FIG. **15** is a front elevation view thereof;

FIG. **16** is a front and right side perspective view thereof;

FIG. **17** is a right side elevation view; the left side elevation view being a mirror image thereof;

FIG. **18** is a top plan view thereof;

FIG. **19** is a rear elevation view of a fourth embodiment of an analysis apparatus in accordance with the new design;

FIG. **20** is a bottom plan view thereof;

FIG. **21** is a front elevation view thereof;

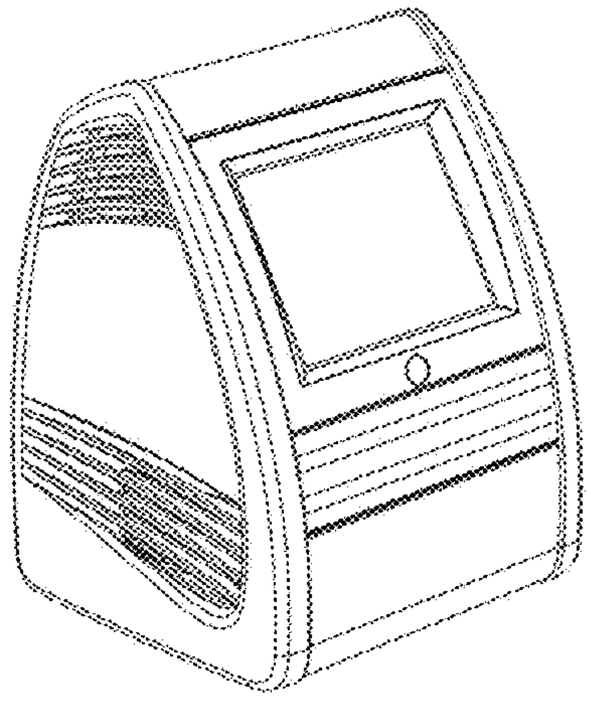
FIG. **22** is a front and right side perspective view thereof;

FIG. **23** is a right side elevation view; the left side elevation view being a mirror image thereof; and,

FIG. **24** is a top plan view thereof.

The broken line showing of structural features is included for the purpose of illustrating non-claimed subject matter and forms no part of the claimed design.

1 Claim, 24 Drawing Sheets



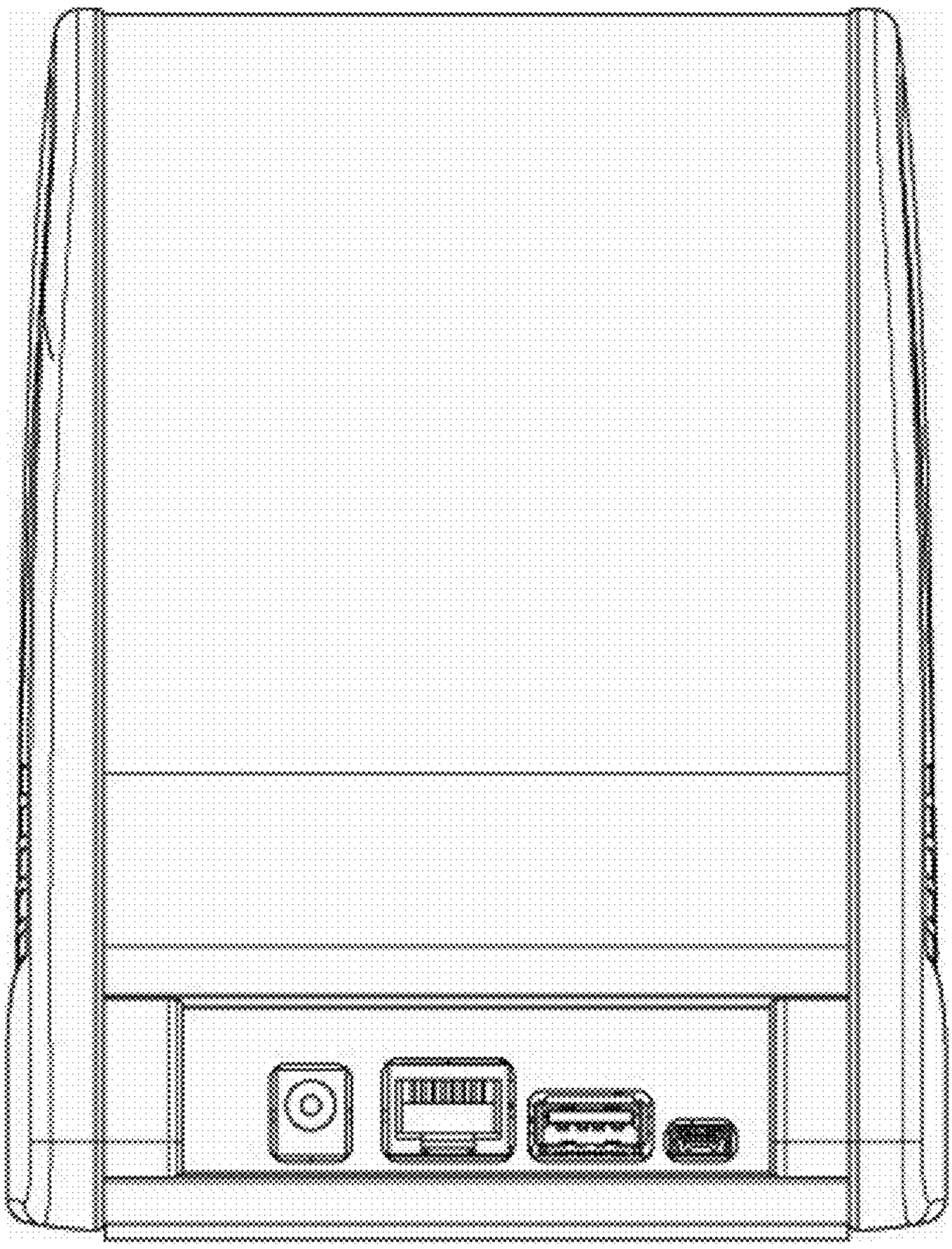


FIG. 1

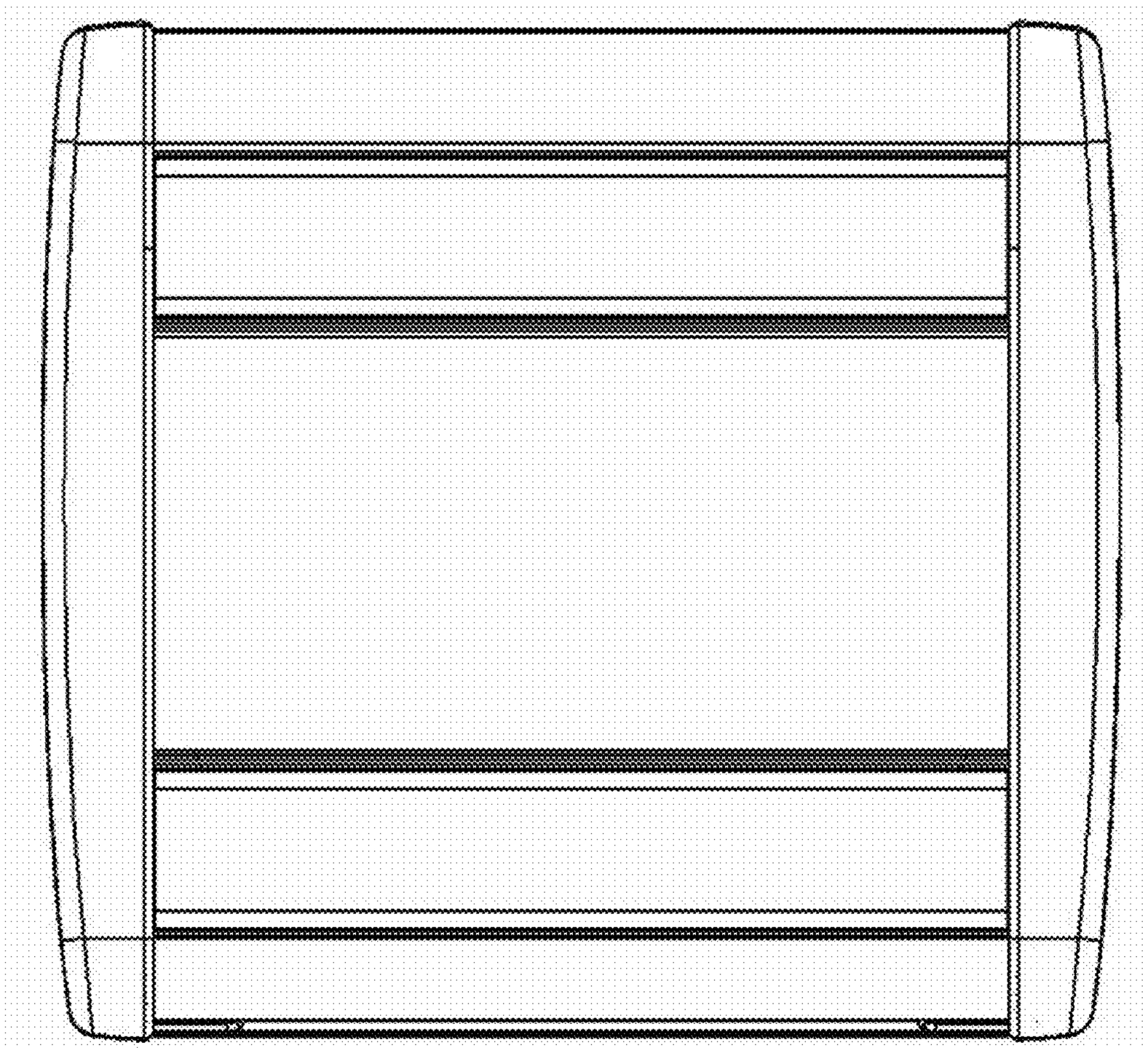


FIG. 2

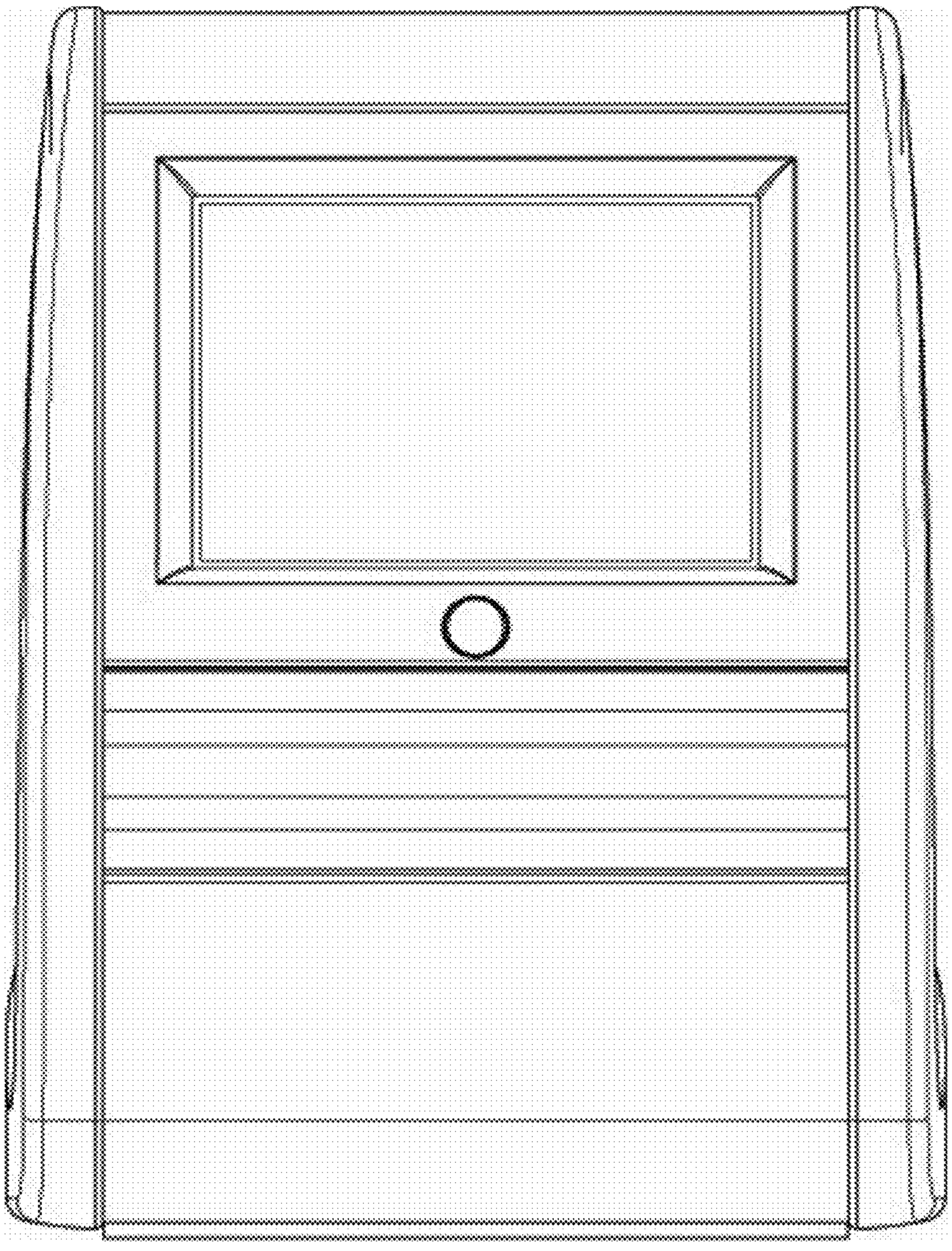


FIG. 3

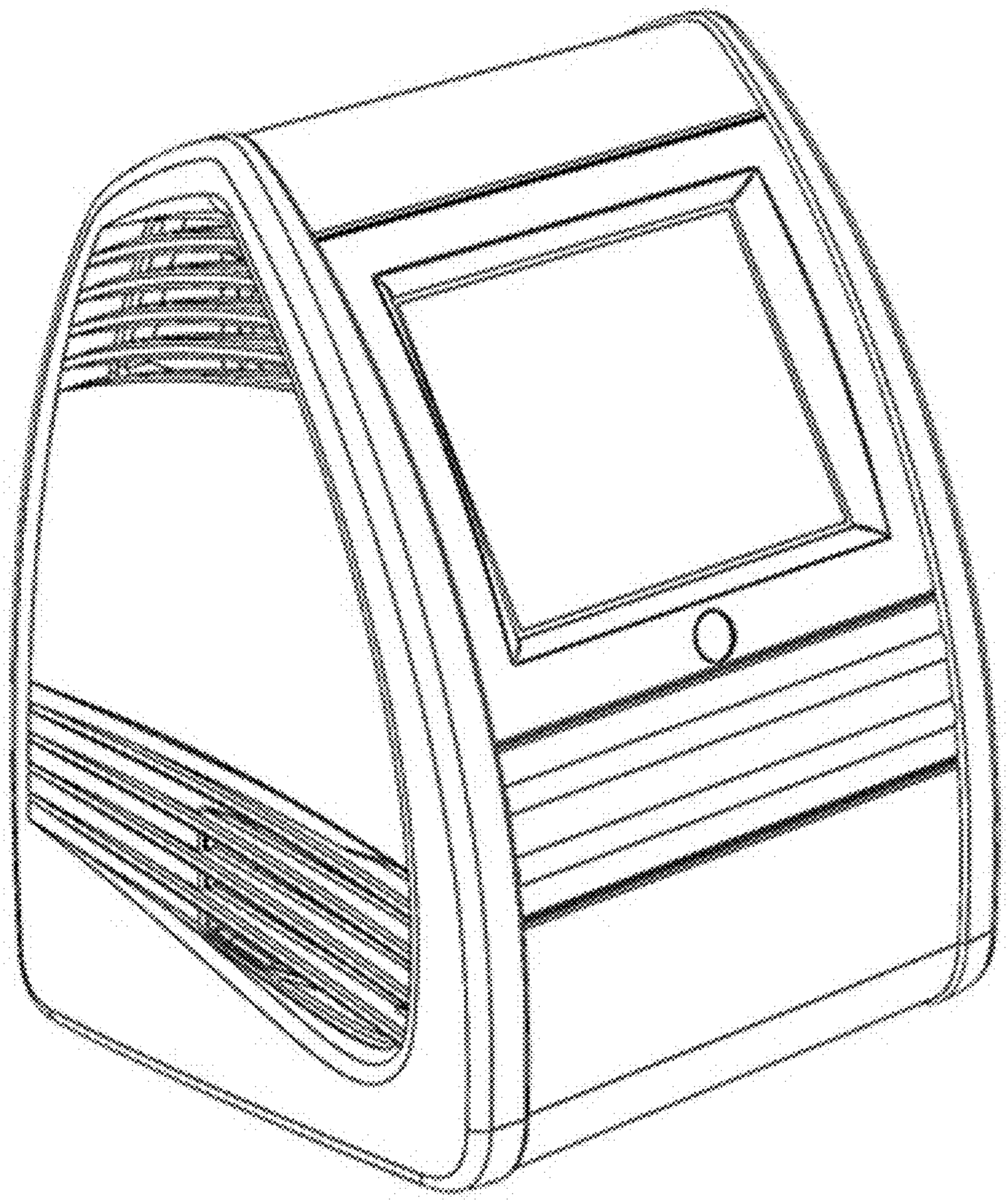


FIG. 4

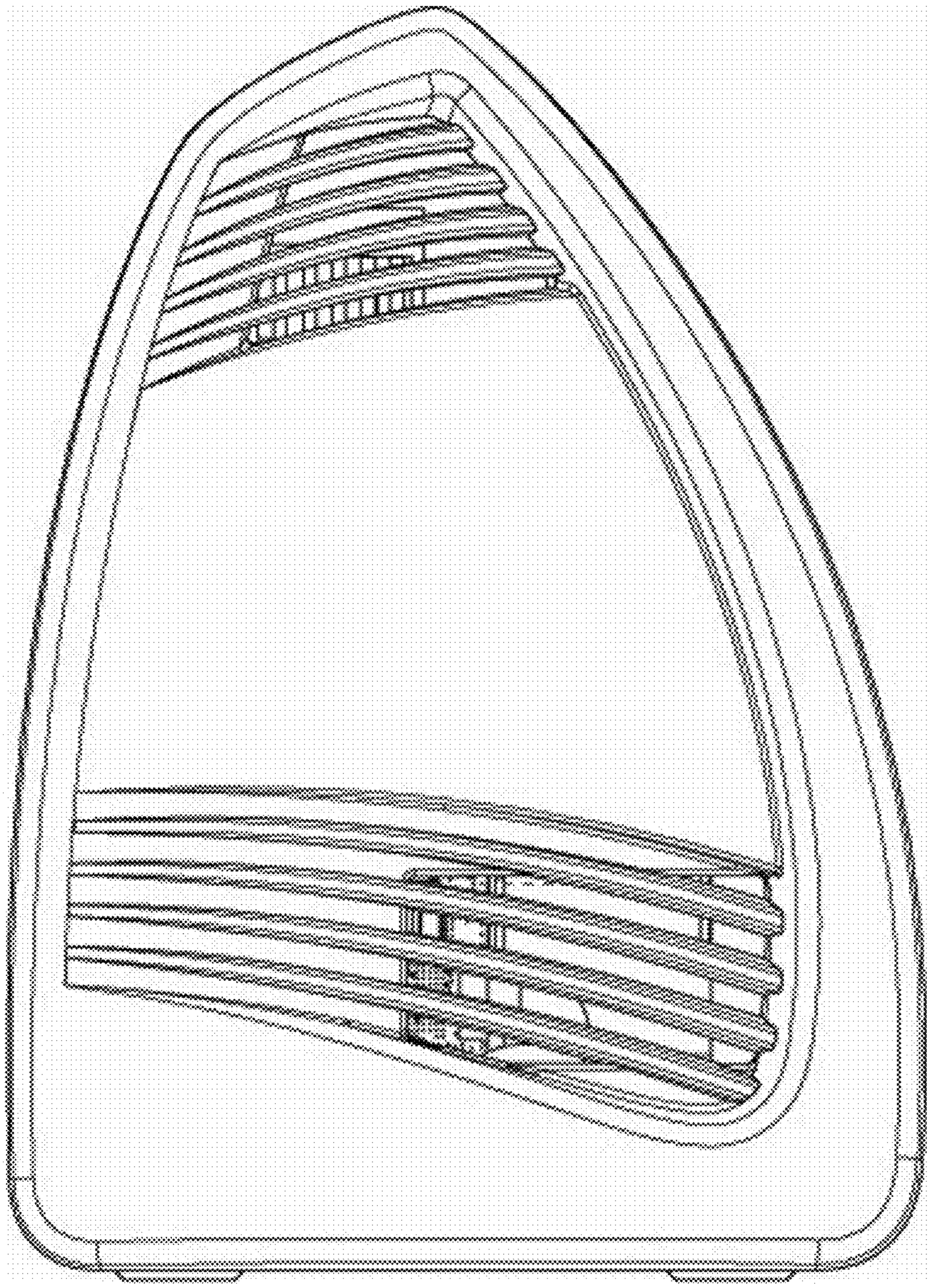


FIG. 5

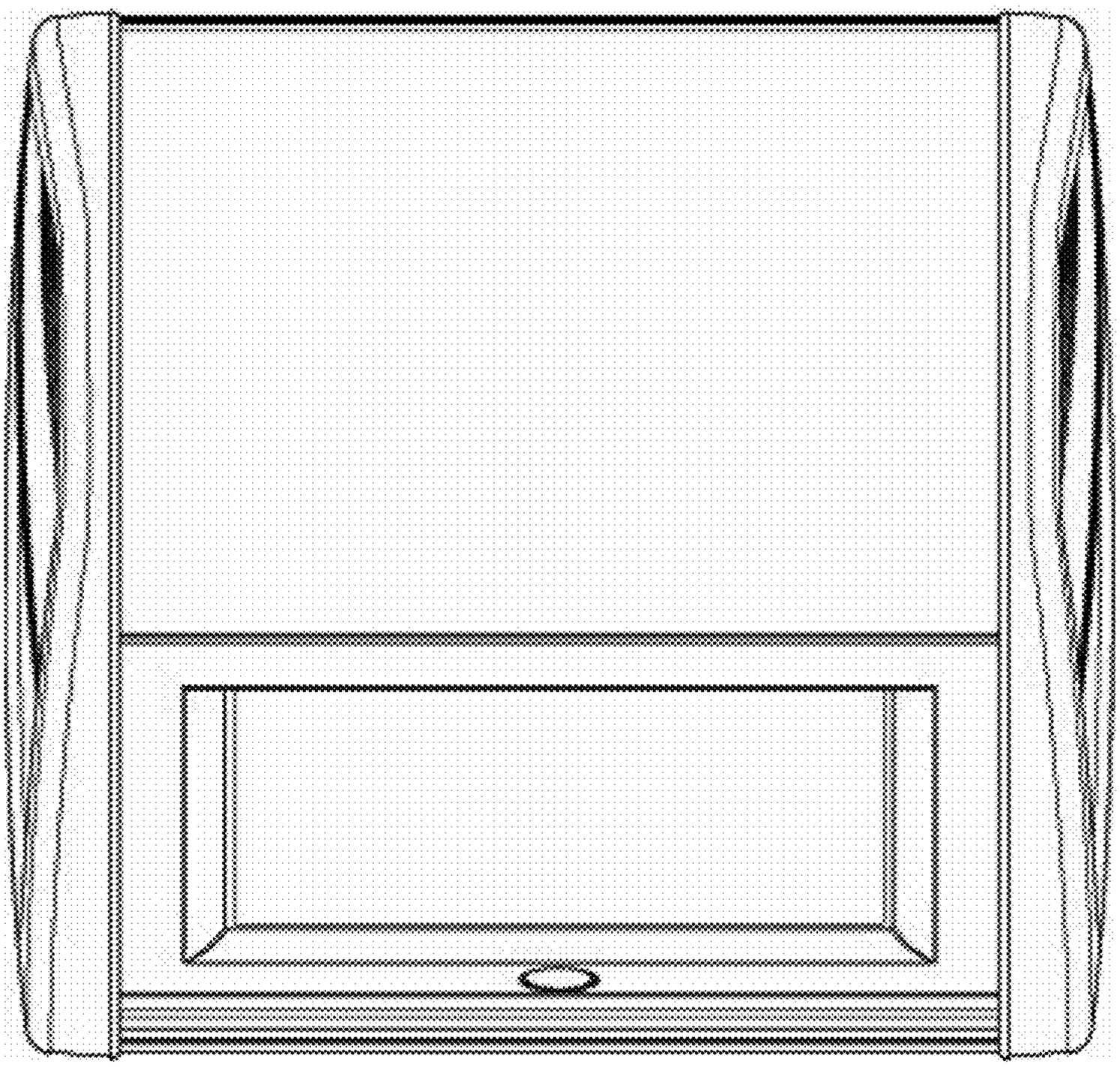


FIG. 6

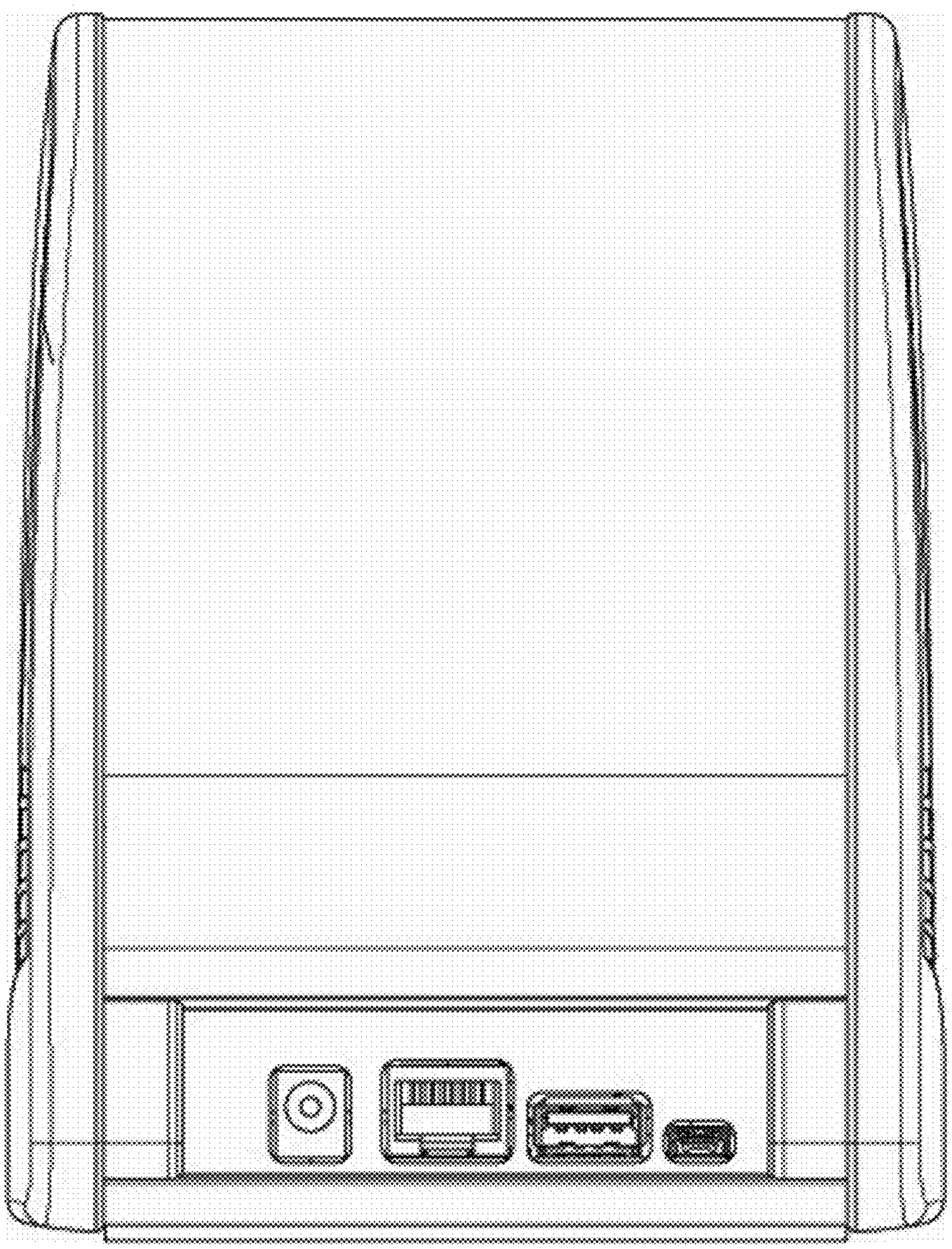


FIG. 7

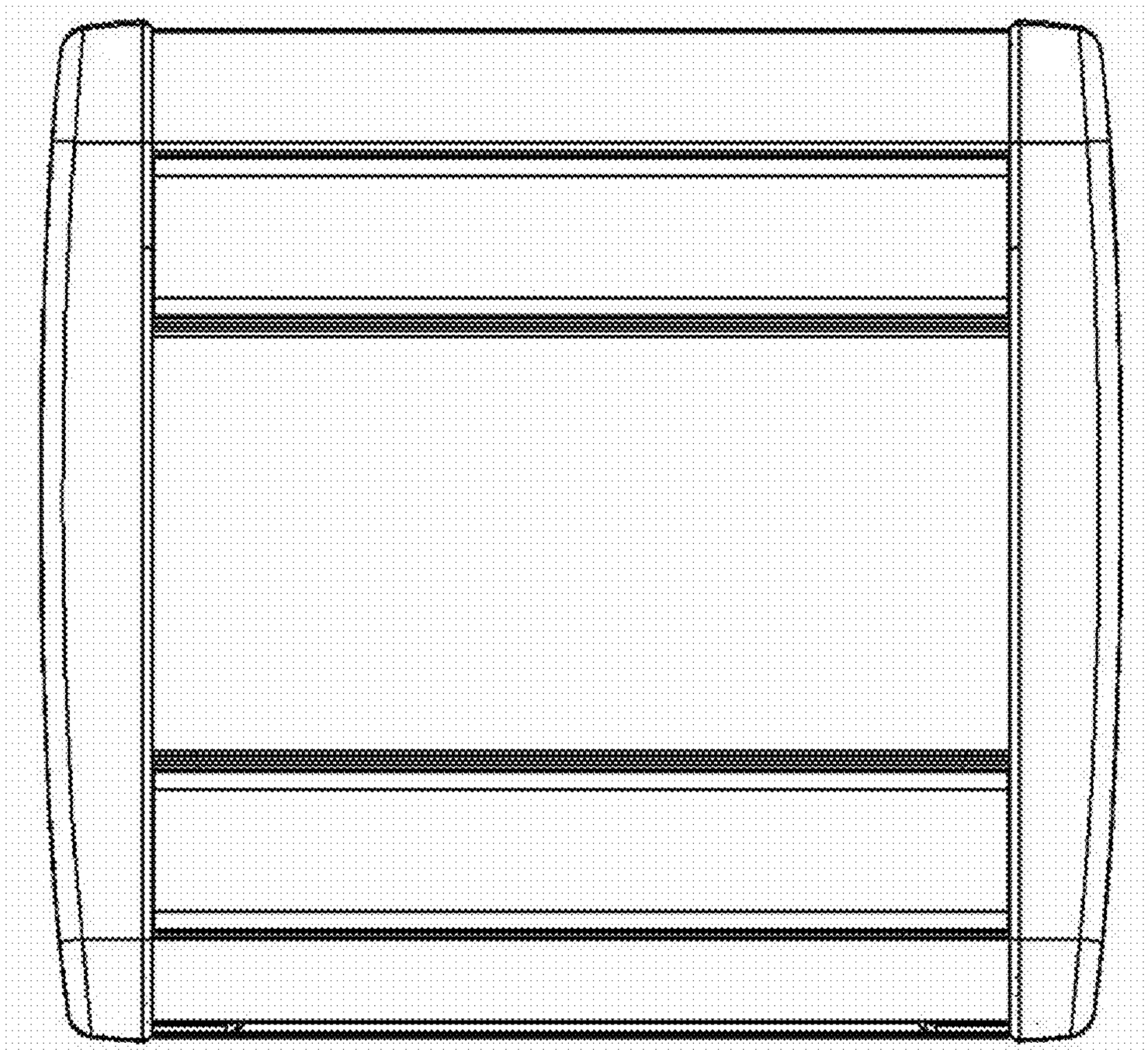


FIG. 8

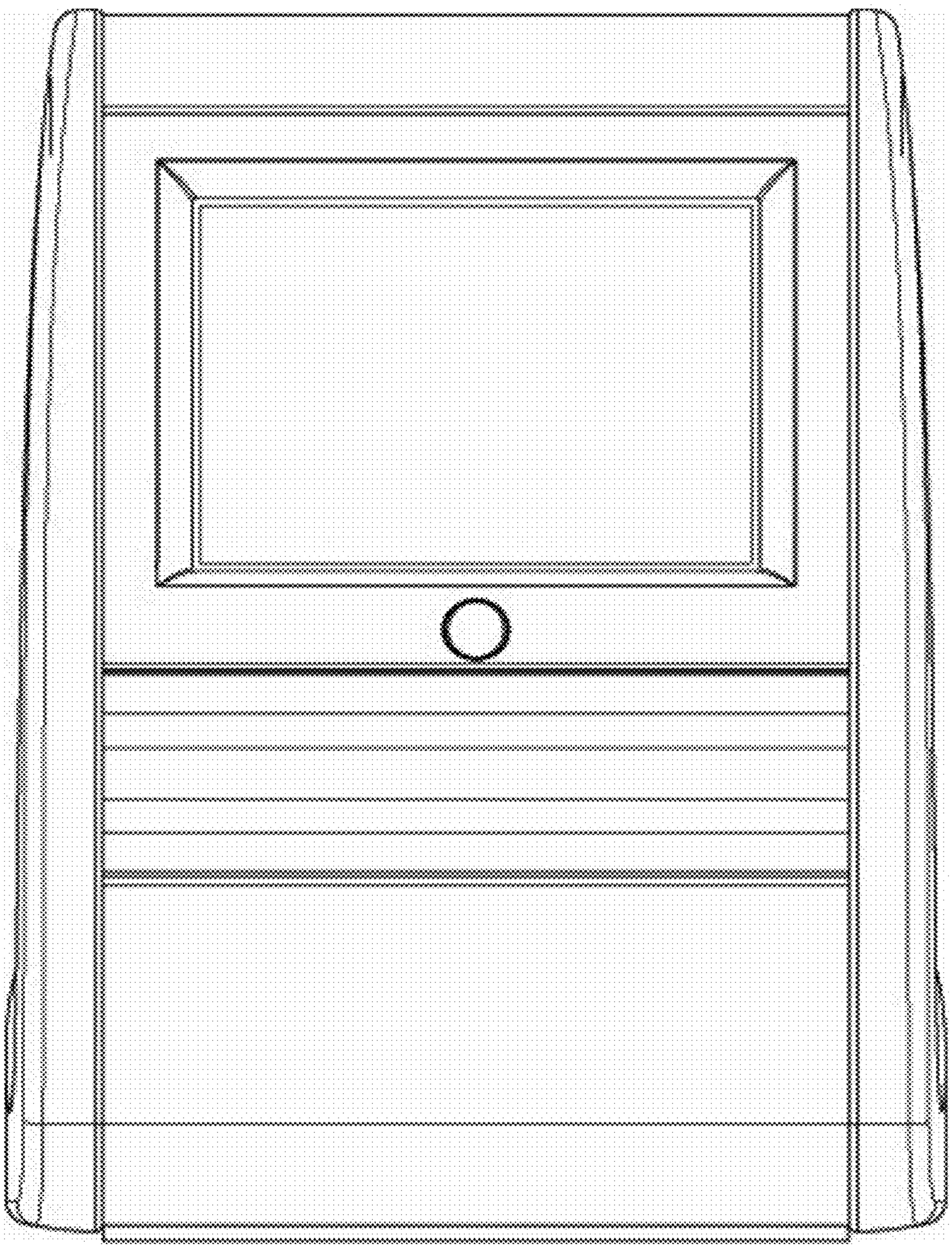


FIG. 9

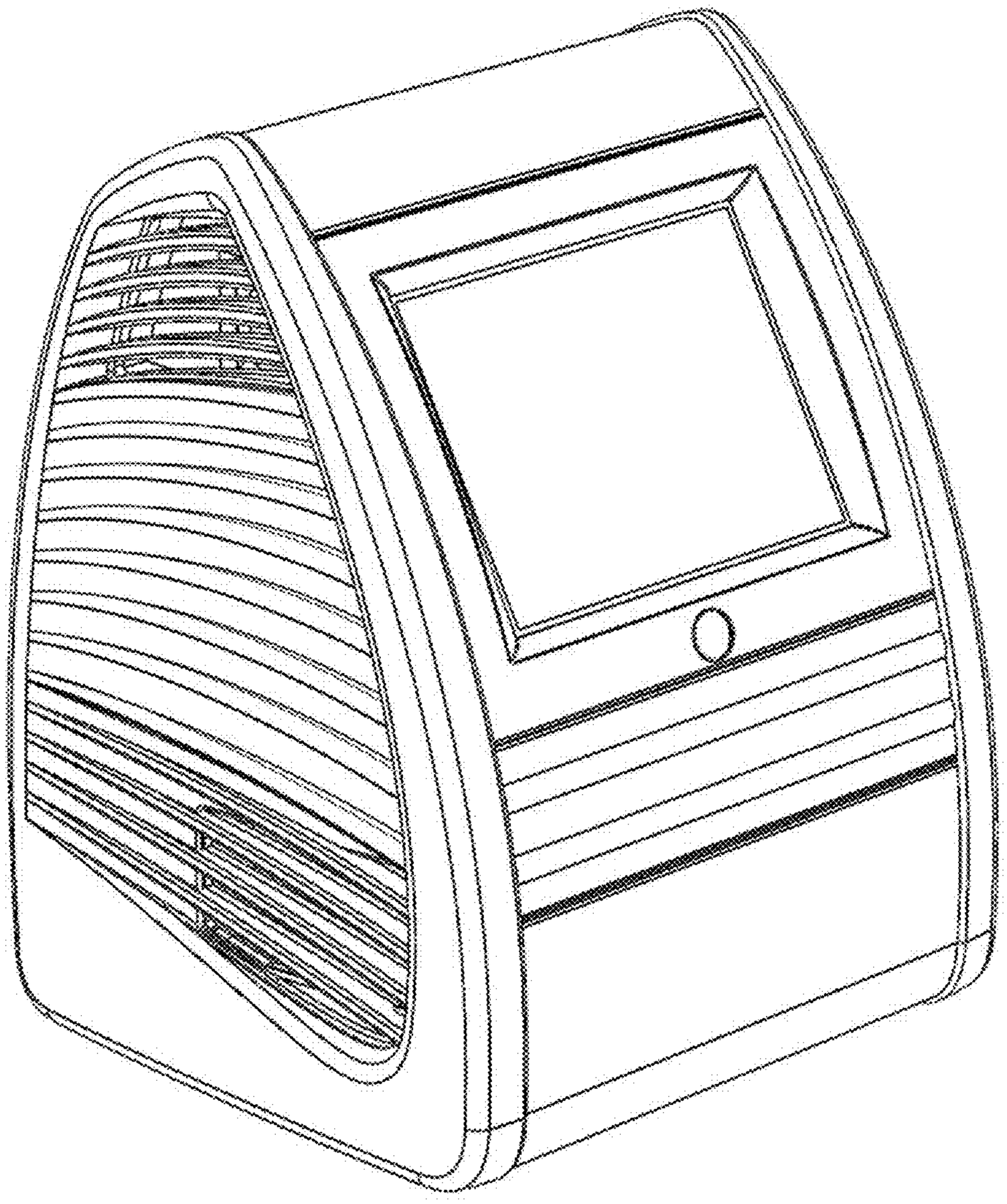


FIG. 10

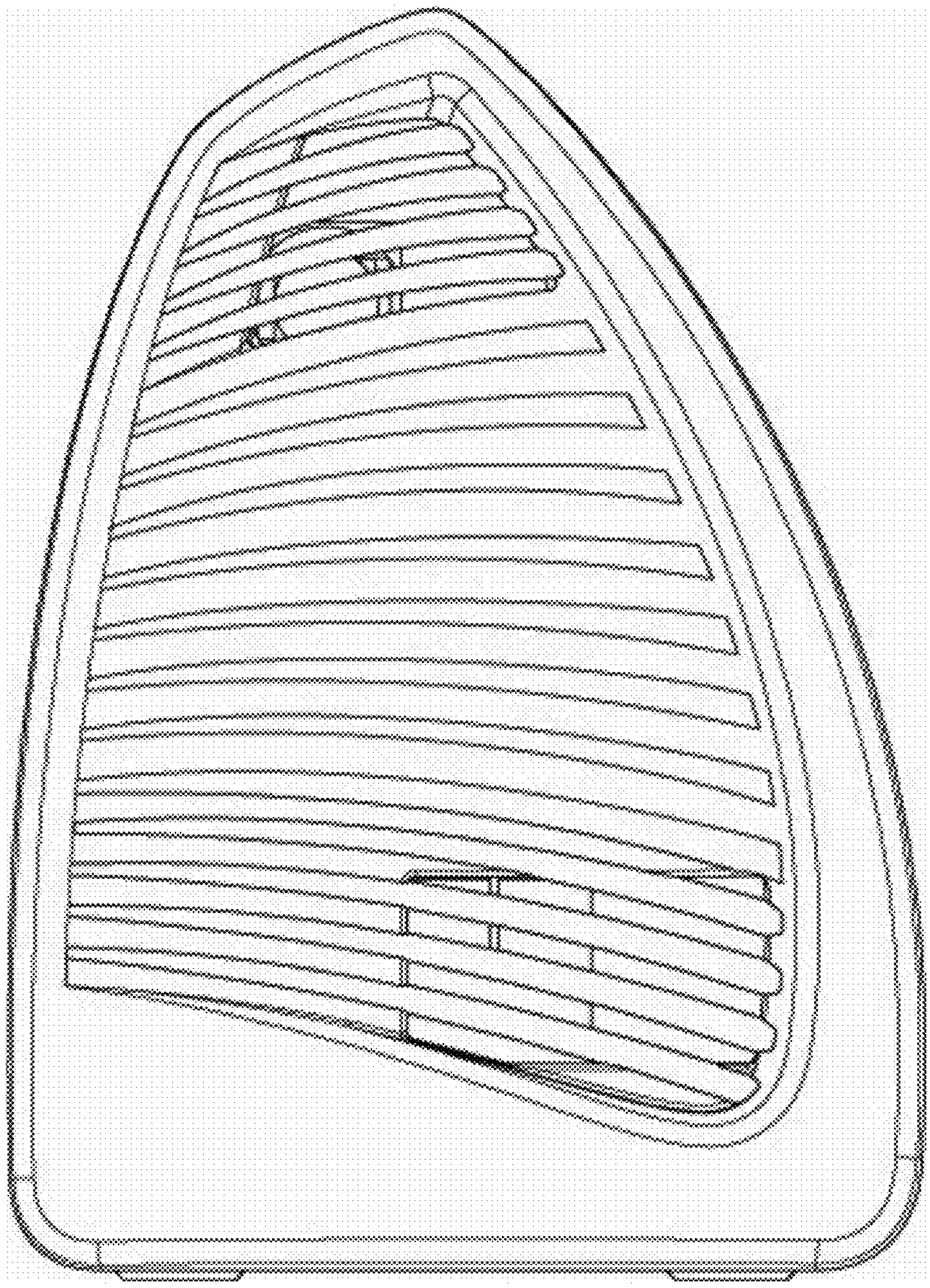


FIG. 11

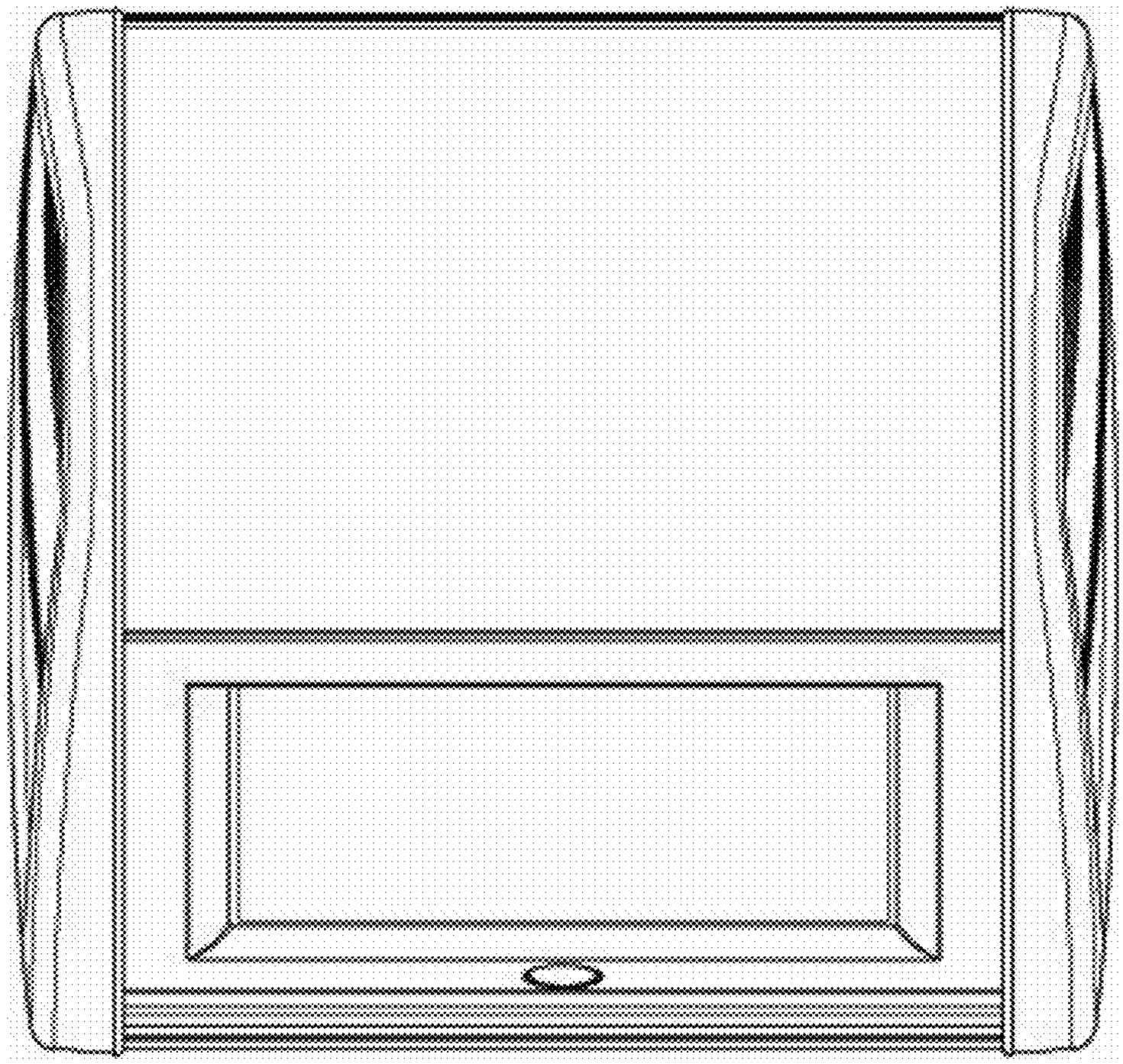


FIG. 12

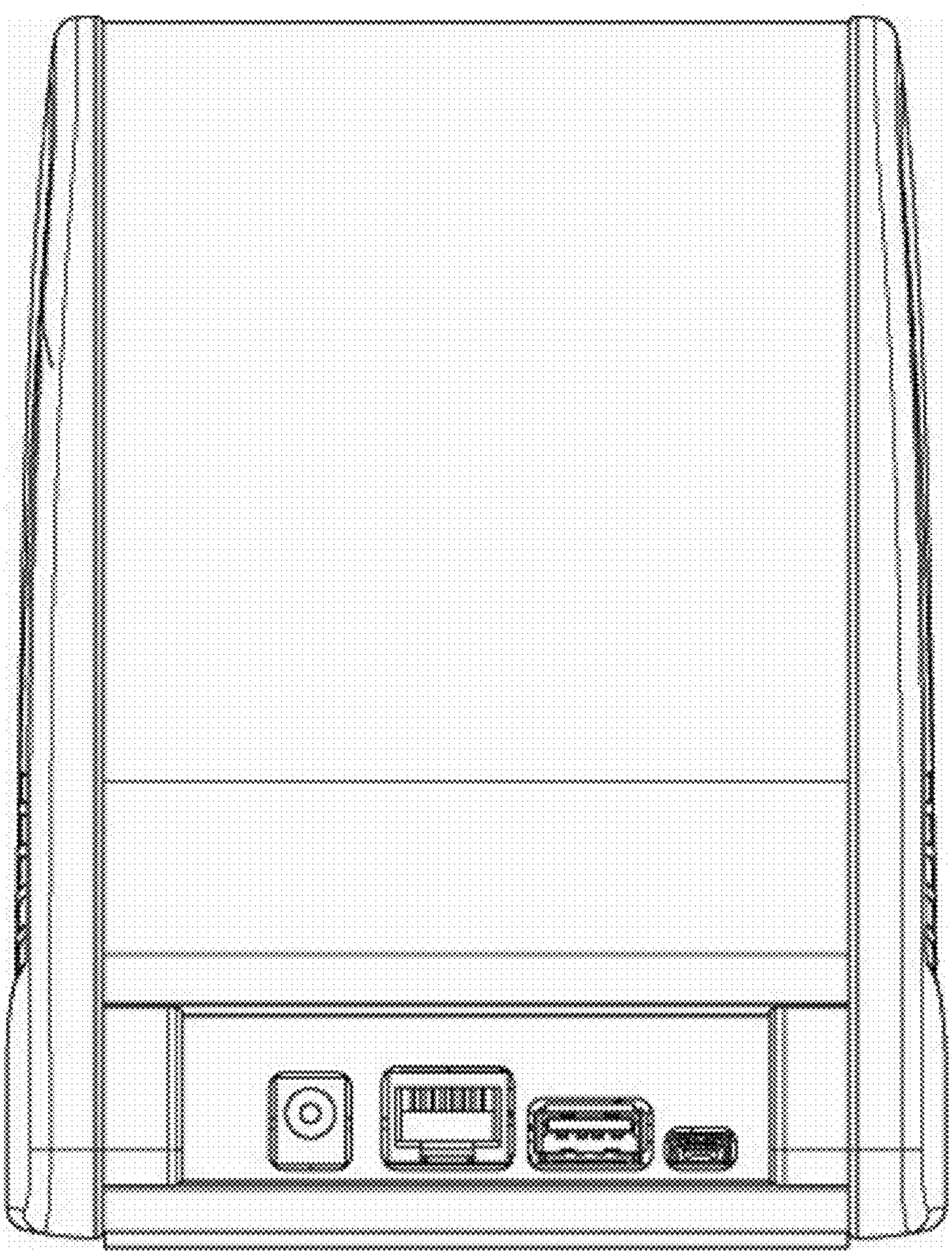


FIG. 13

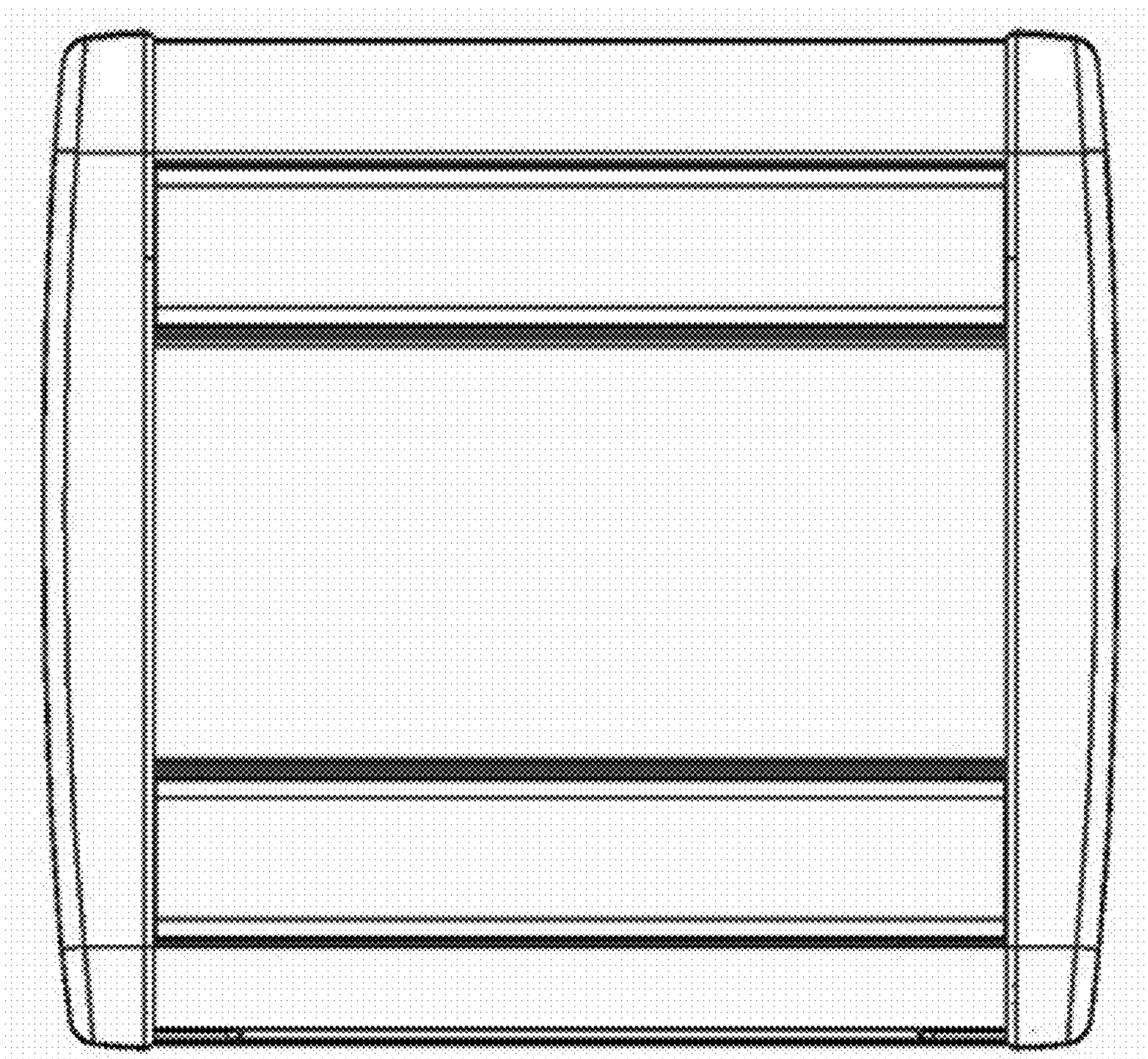


FIG. 14

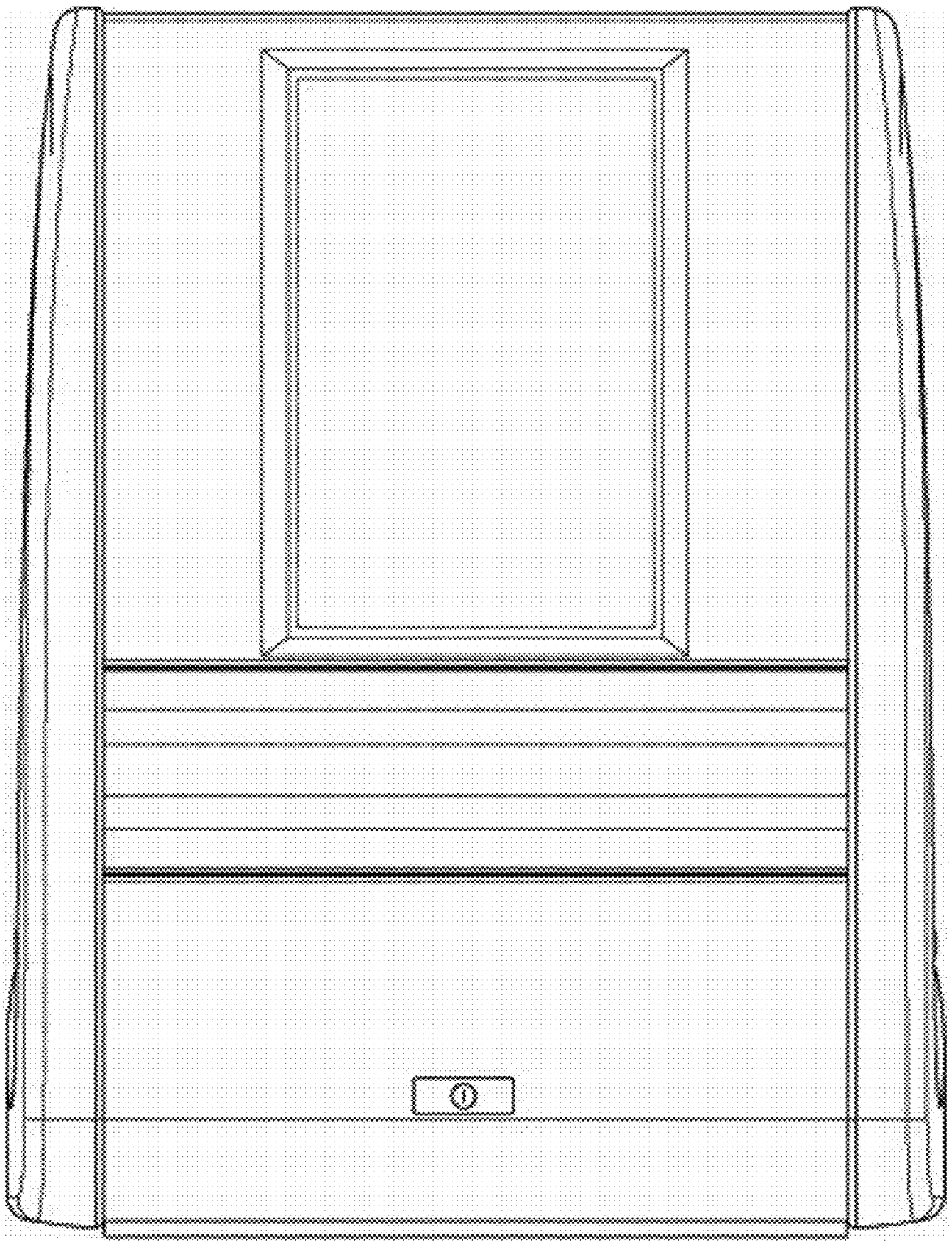


FIG. 15

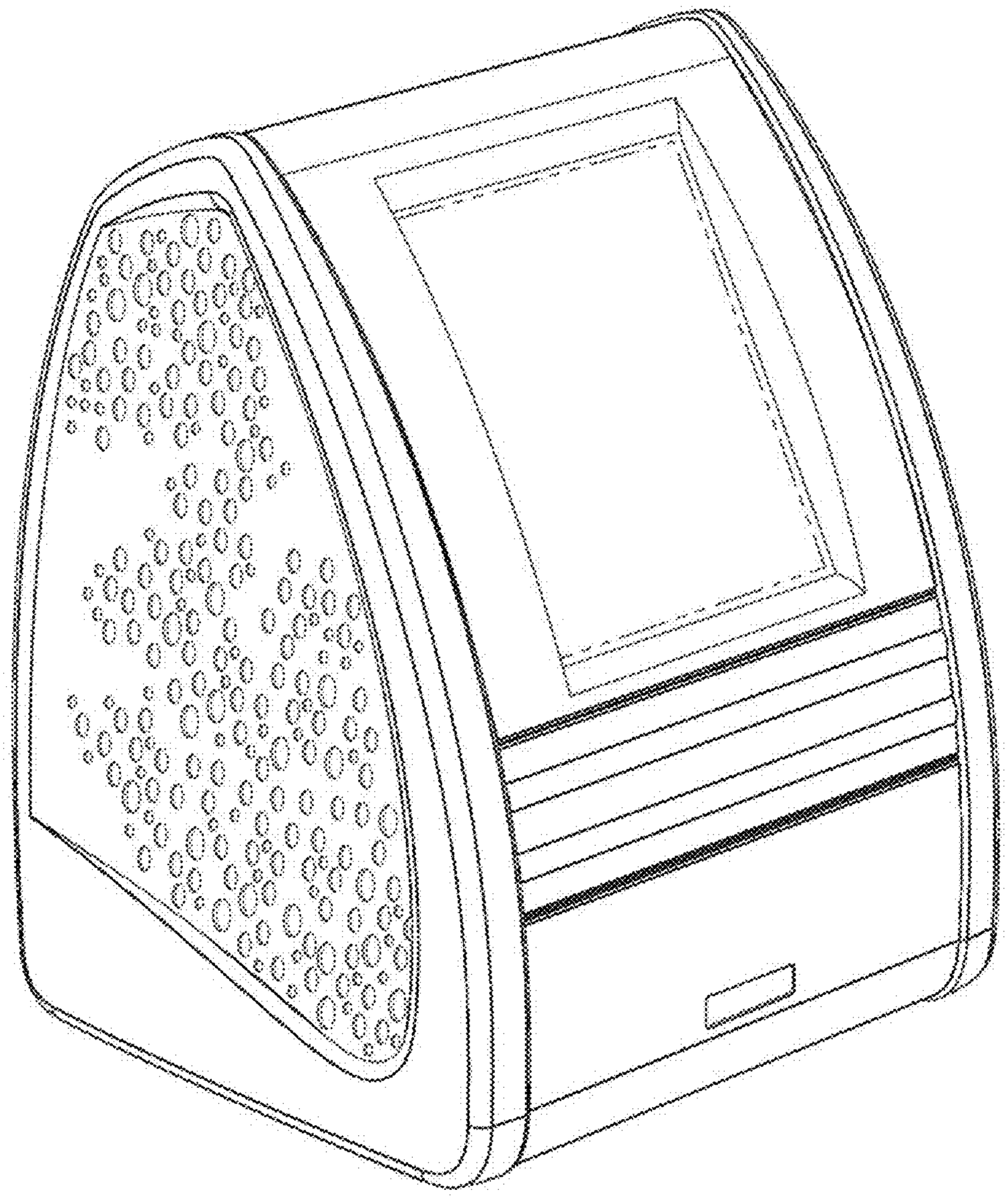


FIG. 16

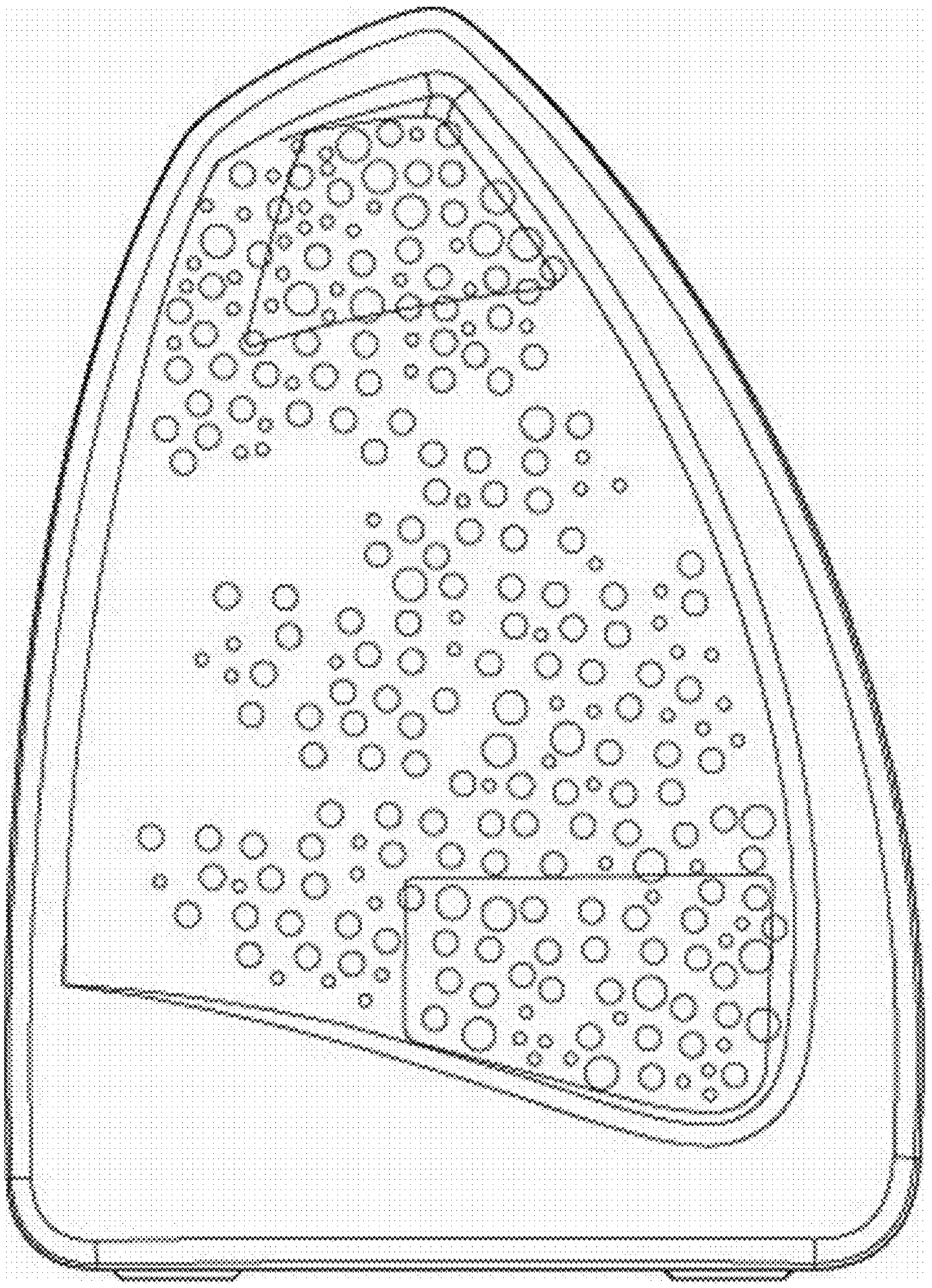


FIG. 17

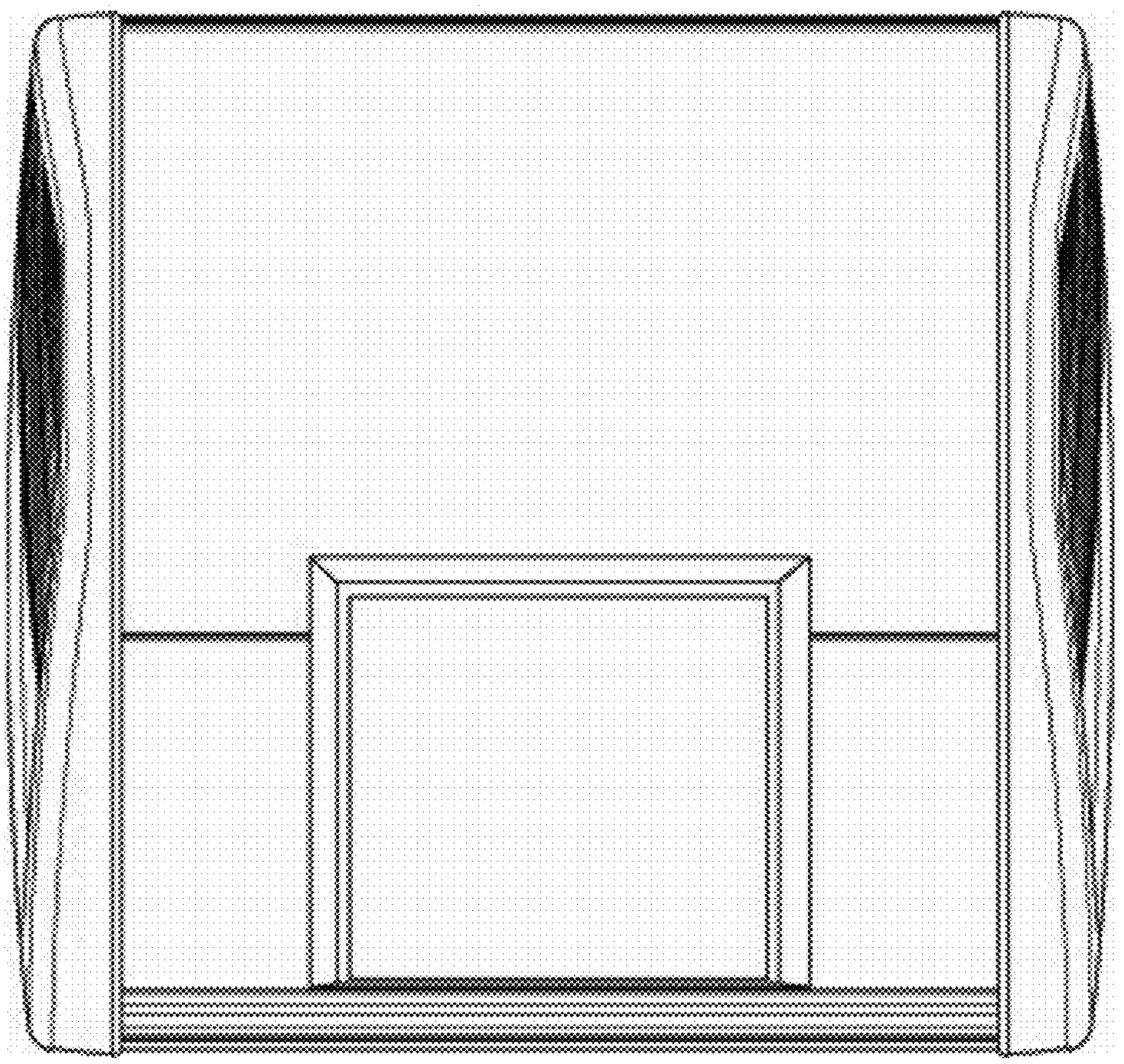


FIG. 18

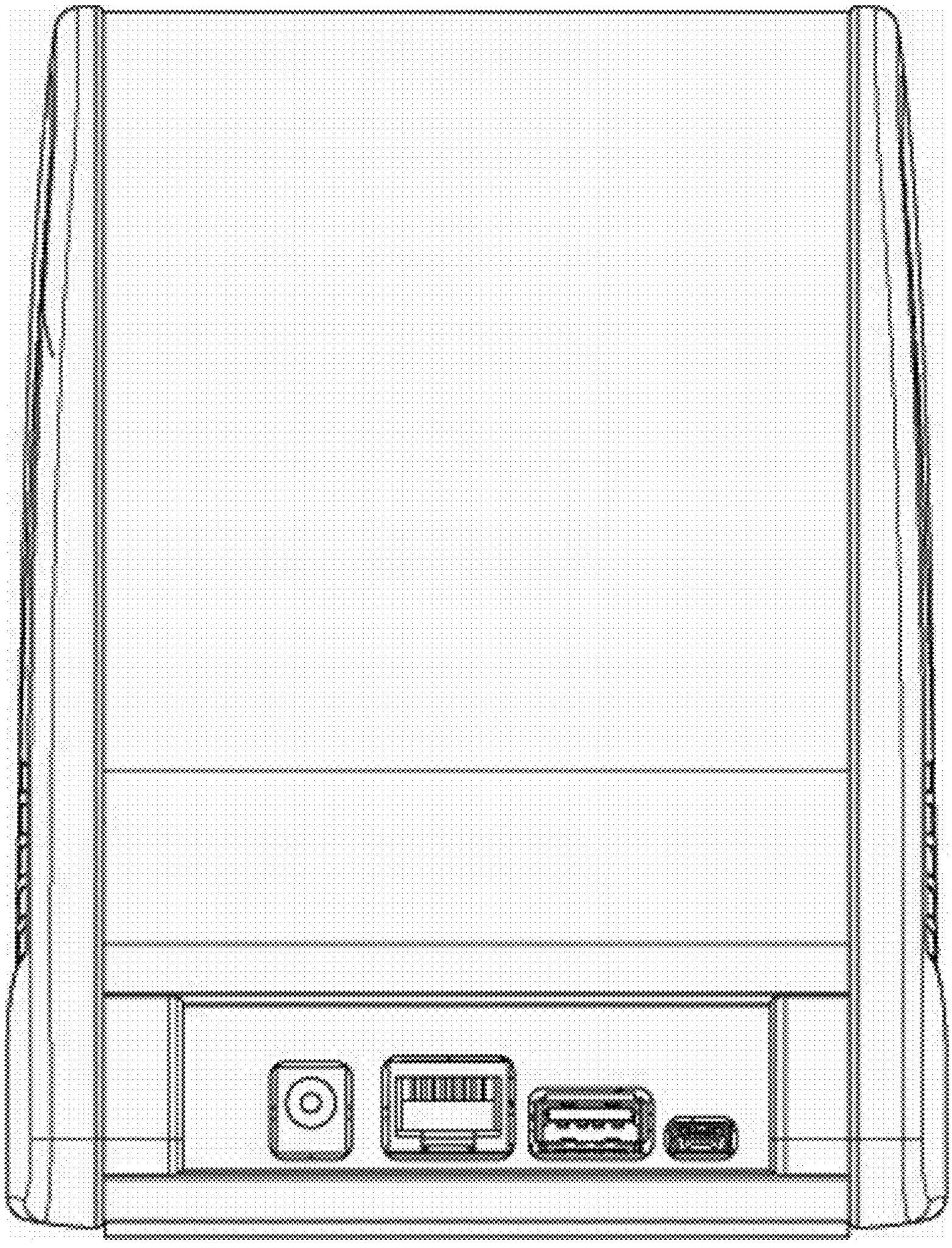


FIG. 19

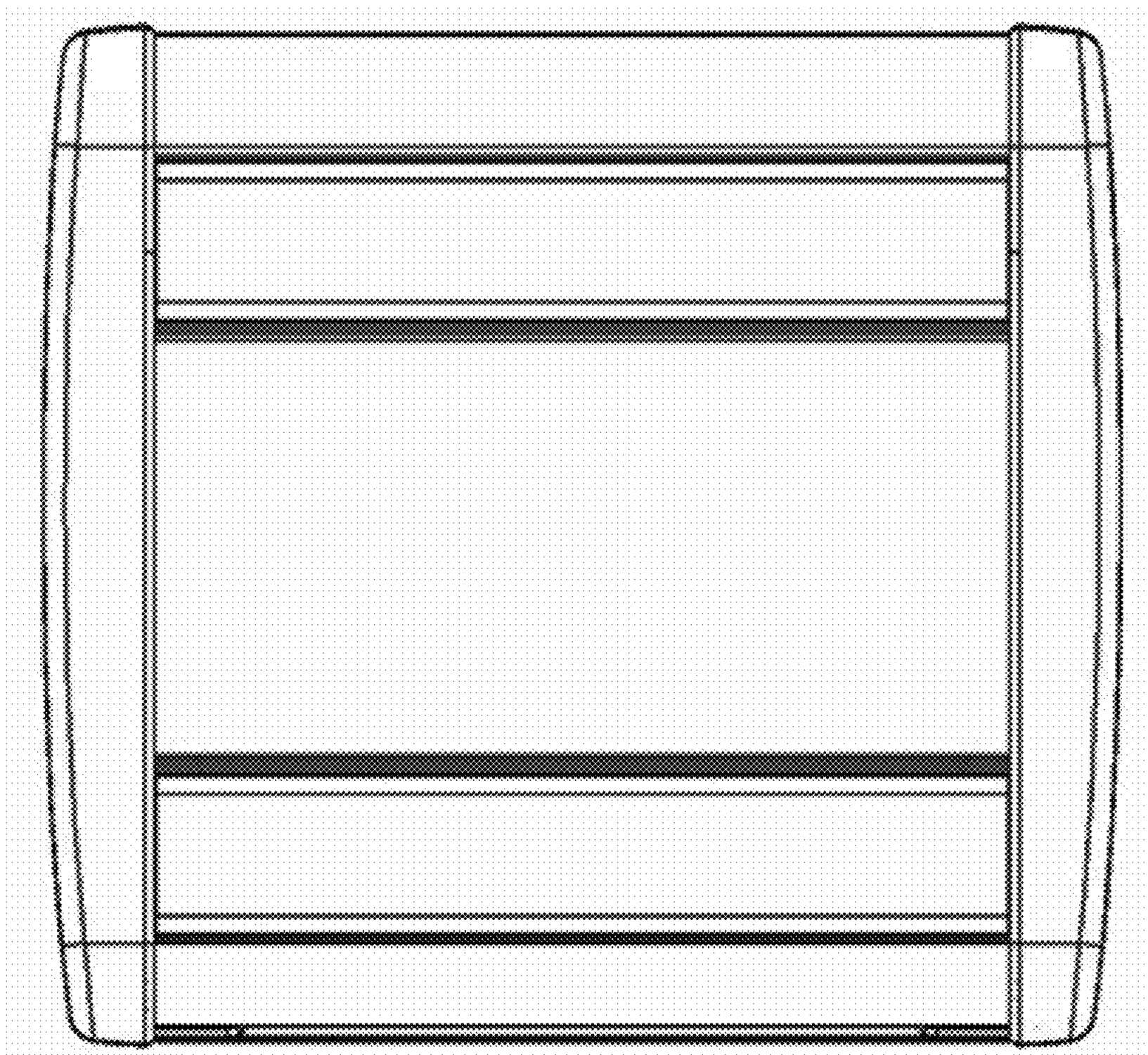


FIG. 20

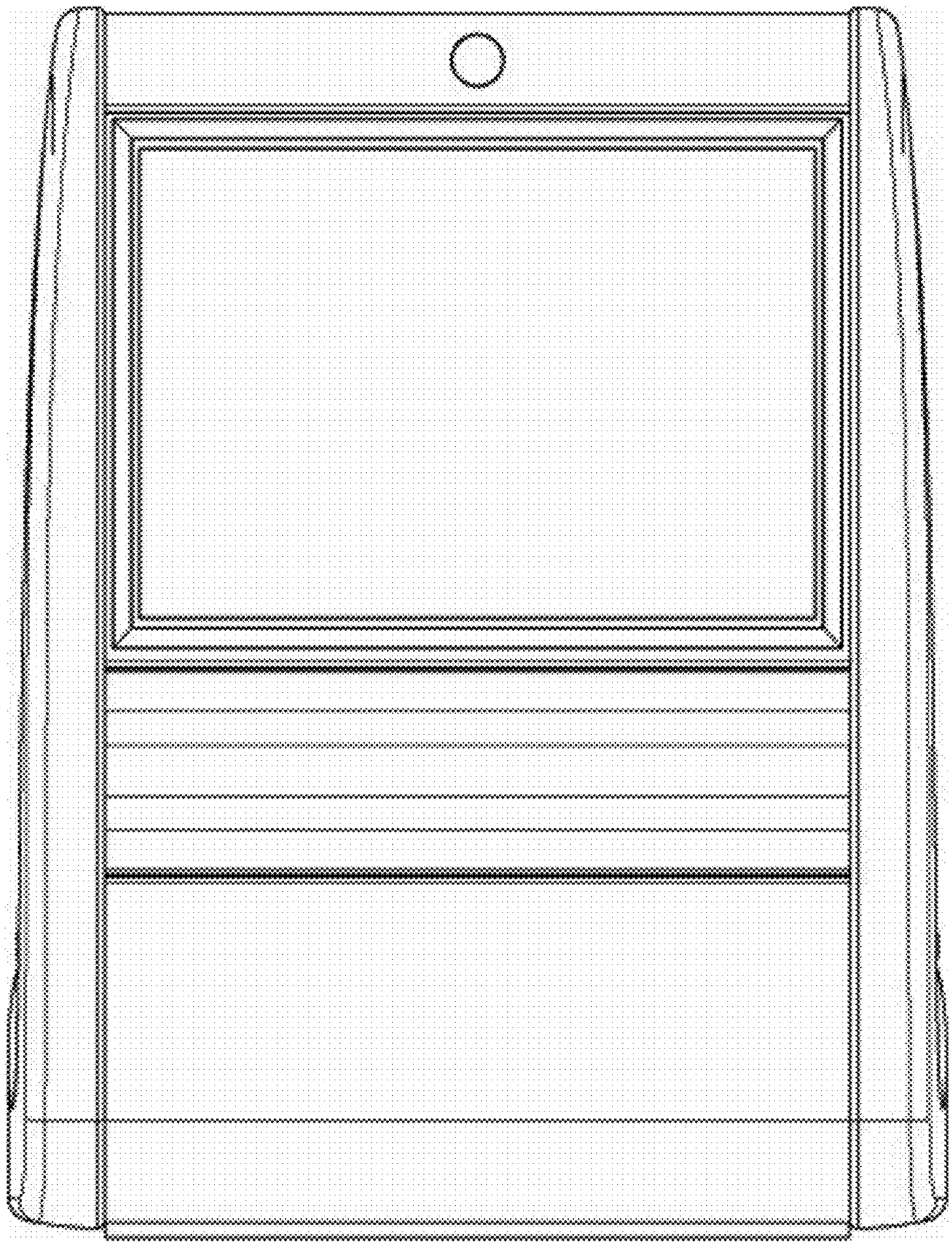


FIG. 21

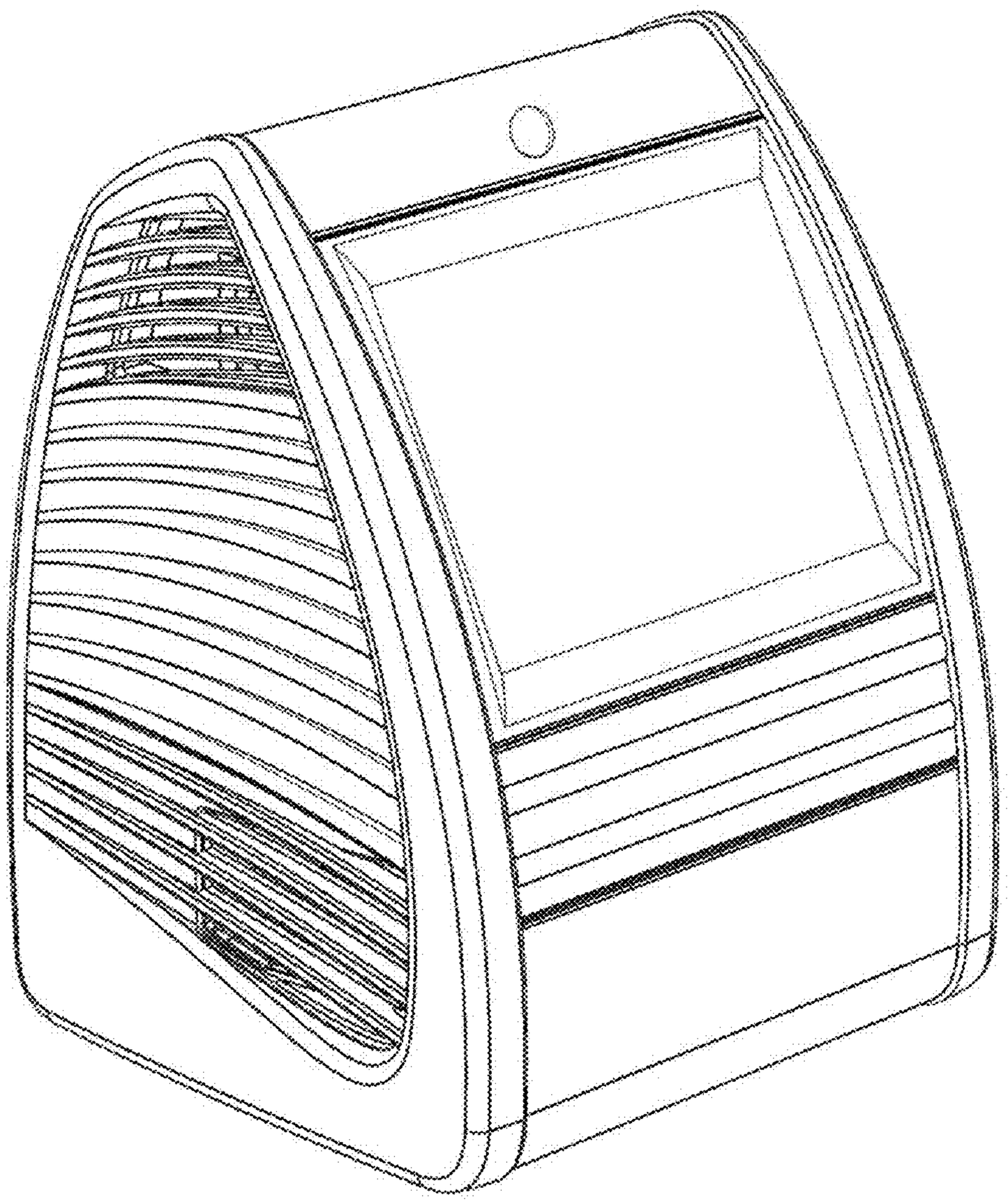


FIG. 22

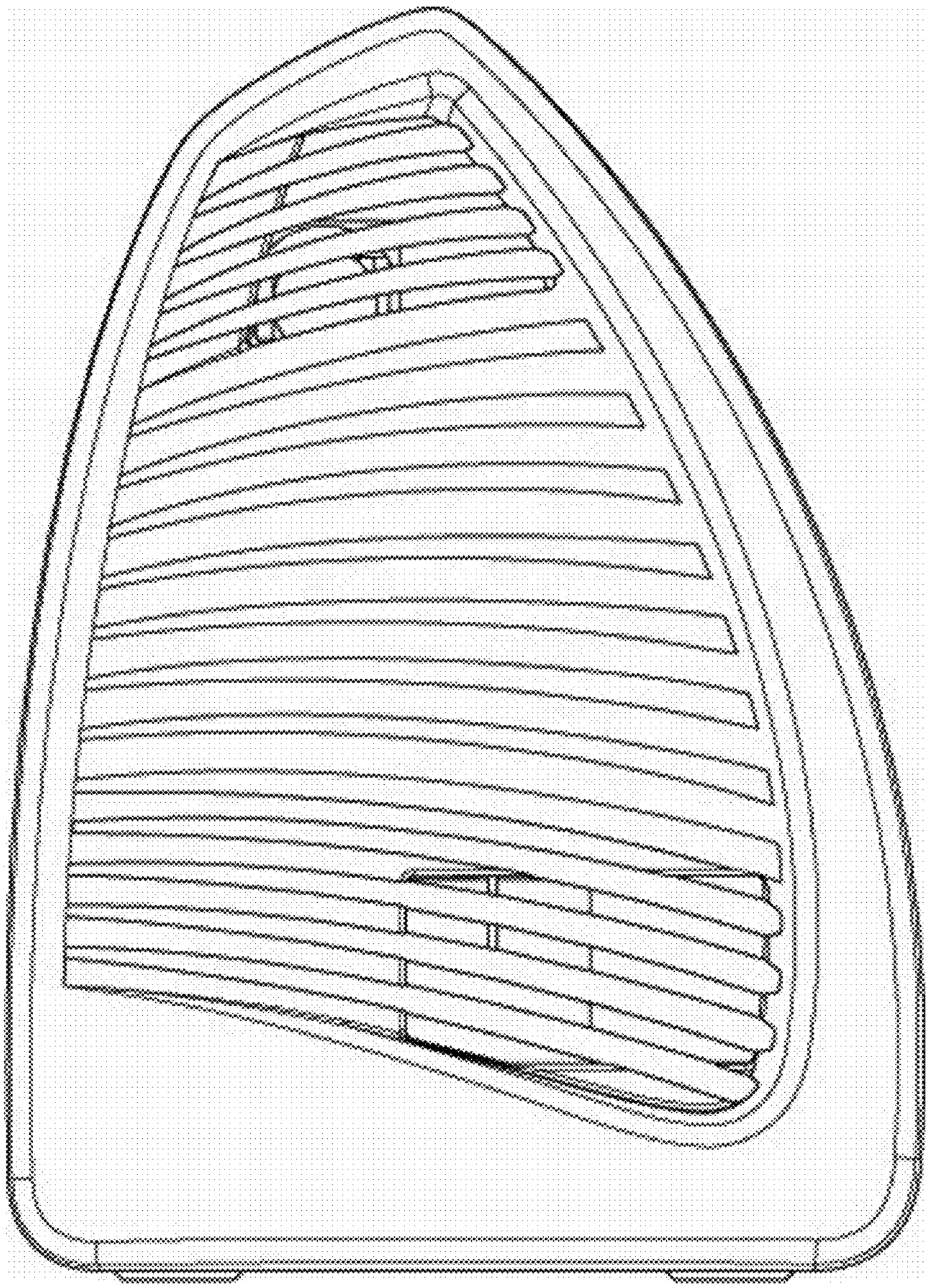


FIG. 23

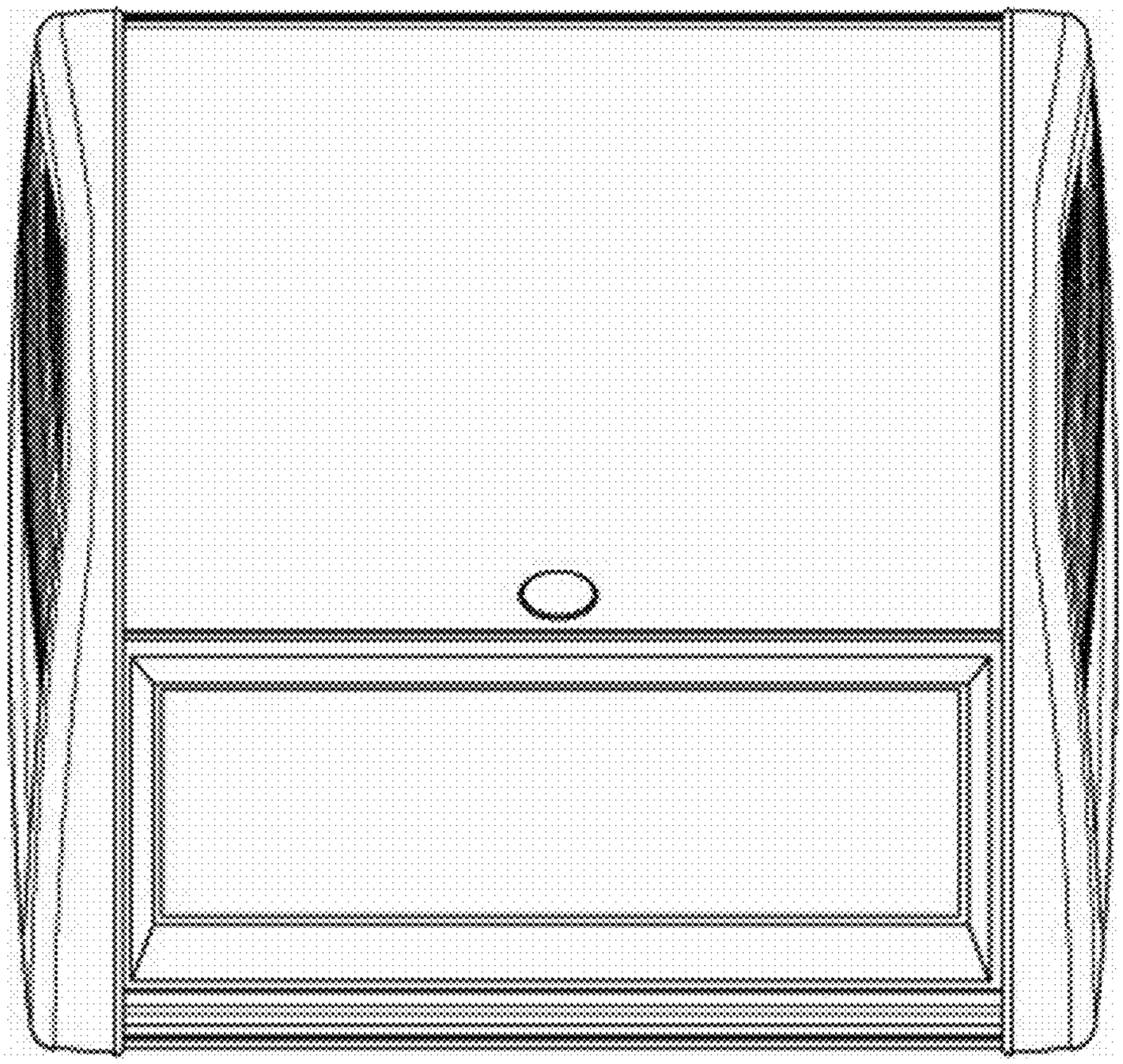


FIG. 24